July 2006



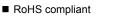
FDD8580/FDU8580 N-Channel PowerTrench[®] MOSFET

FAIRCHILD

FDD8580/FDU8580 N-Channel PowerTrench[®] MOSFET 20V, 35A, 9mΩ

Features

- Max $r_{DS(on)} = 9m\Omega$ at $V_{GS} = 10V$, $I_D = 35A$
- Max $r_{DS(on)}$ =13m Ω at V_{GS} = 4.5V, I_D = 33A
- Low gate charge: Q_{g(TOT)} = 19nC(Typ), V_{GS} = 10V
- Low gate resistance
- 100% Avalanche tested



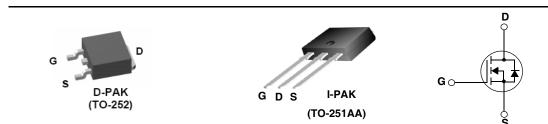


General Description

This N-Channel MOSFET has been designed specifically to improve the overall efficiency of DC/DC converters using either synchronous or conventional switching PWM controllers. It has been optimized for low gate charge, low $r_{DS(on)}$ and fast switching speed.

Application

- Vcore DC-DC for Desktop Computers and Servers
- VRM for Intermediate Bus Architecture



MOSFET Maximum Ratings $T_C = 25^{\circ}C$ unless otherwise noted

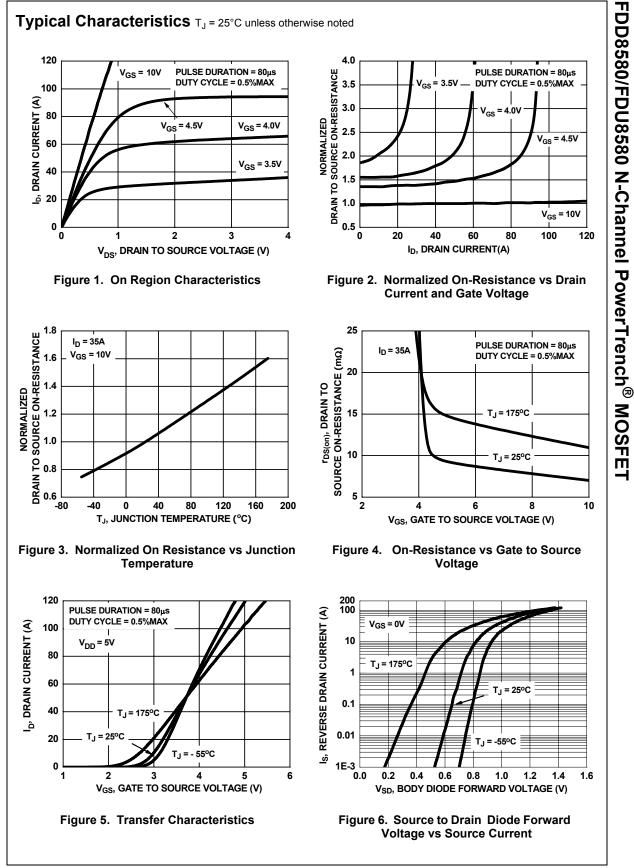
Symbol	Parameter		Ratings	Units
V _{DS}	Drain to Source Voltage		20	V
V _{GS}	Gate to Source Voltage		±20	V
ID	Drain Current -Continuous (Package Limited)		35	
	-Continuous (Die Limited)		58	Α
	-Pulsed	(Note 1)	159	
E _{AS}	Single Pulse Avalanche Energy	(Note 2)	66	mJ
P _D	Power Dissipation		49.5	W
T _J , T _{STG}	Operating and Storage Temperature		-55 to 175	°C

$R_{ ext{ heta}JC}$	Thermal Resistance, Junction to Case TO-252, TO-251	3.03	°C/W
R_{\thetaJA}	Thermal Resistance, Junction to Ambient TO-252, TO-251	100	°C/W
$R_{ ext{ heta}JA}$	Thermal Resistance, Junction to Ambient TO-252,1in ² copper pad area	52	°C/W

Package Marking and Ordering Information

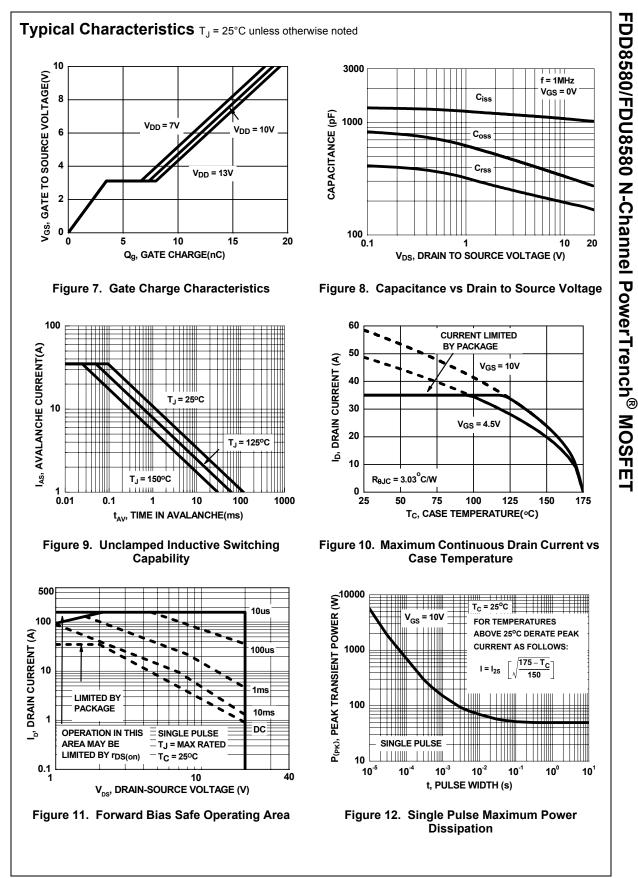
Device Marking	Device	Package	Reel Size	Tape Width	Quantity
FDD8580	FDD8580	TO-252AA	13"	12mm	2500 units
FDU8580	FDU8580	TO-251AA	N/A(Tube)	N/A	75 units

Symbol	Parameter	Test Conditions	Min	Тур	Мах	Units
Off Chara	cteristics					
BV _{DSS}	Drain to Source Breakdown Voltage	I _D = 250μA, V _{GS} = 0V	20			V
$\frac{\Delta BV_{DSS}}{\Delta T_J}$	Breakdown Voltage Temperature Coefficient	$I_D = 250 \mu A$, referenced to $25^{\circ}C$		17.3		mV/°C
I _{DSS}	Zero Gate Voltage Drain Current	$V_{DS} = 16V,$ $V_{GS} = 0V$ $T_J = 150^{\circ}C$			1 250	μA
I _{GSS}	Gate to Source Leakage Current	V _{GS} = ±20V			±100	nA
On Chara	cteristics					
V _{GS(th)}	Gate to Source Threshold Voltage	$V_{GS} = V_{DS}, I_D = 250 \mu A$	1.2	1.8	2.5	V
$\frac{\Delta V_{GS(th)}}{\Delta T_{.1}}$	Gate to Source Threshold Voltage Temperature Coefficient	$I_D = 250 \mu A$, referenced to $25^{\circ}C$		-6.3	2.0	mV/°C
<u> </u>		V _{GS} = 10V, I _D = 35A		6.6	9.0	
r	Drain to Source On Resistance	V _{GS} = 4.5V, I _D = 33A		9.3	13.0	mΩ
r _{DS(on)}		$V_{GS} = 10V, I_D = 35A$ T _{.1} = 175°C		10.6	14.5	
9 _{FS}	Forward Transcondductance	V _{DS} = 5V,I _D = 35A		61		S
Dynamic	Characteristics					
C _{iss}	Input Capacitance			1085	1445	pF
C _{oss}	Output Capacitance	V _{DS} = 10V, V _{GS} = 0V,		340	450	pF
C _{rss}	Reverse Transfer Capacitance	f = 1MHz		205	310	pF
R _g	Gate Resistance	f = 1MHz		1.3		Ω
	g Characteristics			1		
	Turn-On Delay Time			7	14	ns
t _r	Rise Time	V _{DD} = 10V, I _D = 35A		11	20	ns
t _{d(off)}	Turn-Off Delay Time	-V _{GS} = 10V, R _{GS} = 27Ω		59	94	ns
t _f	Fall Time	_		34	54	ns
Q _{g(TOT)}	Total Gate Charge at 10V	V _{GS} = 0V to 10V		19	27	nC
$Q_{g(5)}$	Total Gate Charge at 5V	$V_{GS} = 0V \text{ to } 5V$ $V_{DD} = 10V$ $I_D = 35A$		10	14	nC
Q_{gs}	Gate to Source Gate Charge	$I_{\rm D} = 35A$		3.5	-	nC
<u>∽gs</u> Q _{gd}	Gate to Drain "Miller"Charge	I _g = 1.0mA		3.9		nC
	urce Diode Characteristics	1		1	1	1
V	Source to Drain Diode Forward Voltage	V _{GS} = 0V, I _S = 15A		0.95	1.25	- V
V _{SD}				0.85	1.2	
t	Reverse Recovery Time	I _F = 35A, di/dt = 100A/μs		26	39	ns
t _{rr} Q _{rr}	Reverse Recovery Charge	I _F = 35A, di/dt = 100A/μs		19	29	nC

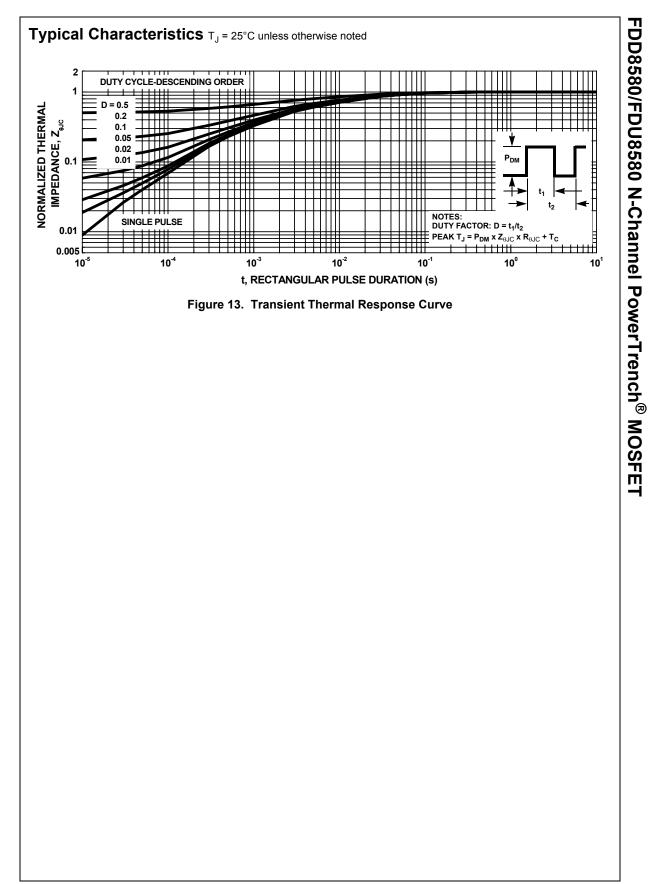


FDD8580/FDU8580 Rev. A

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FDD8580/FDU8580 Rev. A



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